

10/583137
AP20 Rec'd PCT/PTO 16 JUN 2006

Docket No.: 4590-535

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Arnaud BAILLEUL et al.

U.S. Patent Application No. *not yet assigned*

Filed: *herewith*

For: METHOD FOR VERIFYING RULES ON UML MODELS

:
:
: Confirmation No.
:
:
:
:

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Please note this is a PCT application in the entry of the National Phase in the U.S. and copies of the references cited were transmitted by WIPO and are believed to be in the file of the above-identified application and readily available to the Examiner. Therefore it is believed that Applicants have met all requirements regarding duty of disclosure under 37 CFR 1.56. A copy of the foreign search report is attached for the Examiner's information. Acknowledgement and consideration of these documents are respectfully requested.

Respectfully submitted,

LOWE HAUPTMAN & BERNER, LLP

Kenneth M. Berner

Kenneth M. Berner
Registration No. 37,093

1700 Diagonal Road, Suite 310
Alexandria, Virginia 22314
(703) 684-1111 KMB/iy
Facsimile: (703) 518-5499
Date: June 16, 2006

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 4590-535		U.S. APPLICATION NO. 10/583137 Not yet assigned			
				APPLICANT Arnaud BAILLEUL et al.					
				FILING DATE herewith		GROUP			
U.S. PATENT DOCUMENTS									
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE			
FOREIGN PATENT DOCUMENTS									
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation			
						Yes	No		
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)									
Campbell L A et al: Automatically detecting and visualizing errors in UML diagrams" Requir. Eng. (UK), Requirements Engineering, 2002 pages 264-287									
Shrotri U et al: "Model checking visual specification of requirements" September 22, 2003 Proceedings First International Conference on Software Engineering and Formal Methods.									
Il-Kyu Ha et al: "Meta-validation of UML structural diagrams and behavioral diagrams with consistency rules" 2003 IEEE Pacific Rim Conference on Communications Computers and Signal Processing" pages 679-683									
Bouassida N et al: "Formalizing the framework design language F-UML" Proceedings First International Conference on Software Engineering and Formal Methods September 22, 2003 pages 164-172									
EXAMINER				DATE CONSIDERED					

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.